## Notice of References Cited Application/Control No. 10/573,044 Examiner LEON-VIET Q. NGUYEN Applicant(s)/Patent Under Reexamination SHIRAKATA ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,317,098 B1	11-2001	Andrews et al.	343/797
*	В	US-2002/0191535 A1	12-2002	Sugiyama et al.	370/208
*	С	US-2003/0072255 A1	04-2003	Ma et al.	370/208
*	D	US-2005/0147186 A1	07-2005	Funamoto et al.	375/324
*	Е	US-2007/0263667 A1	11-2007	Dubuc et al.	370/500
*	F	US-7,436,757 B1	10-2008	Wilson et al.	370/203
	G	US-			
	Ι	US-			
	_	US-			
	٦	US-			
	K	US-			
	┙	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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	х						

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